

### 1. Scope

This specification is applied to Multilayer Ceramic Chip Capacitor (MLCC) for use in electric equipment for the voltage is ranging from 100V to 630V.

The MLCC support for Lead-Free wave and reflow soldering, and electrical characteristic and reliability are same as before. (This product is compliant with the RoHS.)

#### 2. Parts Number Code

С	1206	X	102	K	101	Т
(1)	(2)	(3)	(4)	(5)	(6)	(7)

### (1)Product

Product Code	
С	Multilayer Ceramic Chip Capacitor

### (2)Chip Size

<u> </u>		
Code	Length×Width	unit : mm(inch)
0201	0.60× 0.30	(.024× .011)
0402	1.00× 0.50	(.039× .020)
0603	1.60× 0.80	(.063× .031)
0805	2.00× 1.25	(.079× .049)
1206	3.20× 1.60	(.126× .063)
1210	3.20× 2.50	(.126× .098)
1808	4.60× 2.00	(.181× .079)
1812	4.60× 3.20	(.181× .125)
1825	4.60× 6.35	(.181× .250)
2208	5.70× 2.00	(.220× .197)
2211	5.70× 2.80	(.220× .110)
2220	5.70× 5.00	(.220× .197)
2225	5.70× 6.35	(.220× .250)

# (3)Temperature Characteristics

Code	Temperature	Temperature	Temperature
	Characteristic	Range	Coefficient
N	NPO	-55°C ~+125°C	30 ppm/℃
L	SL	-25°C ~+85°C	+350~-1000ppm
Χ	X7R	-55°C ~+125°C	± 15%
В	X5R	-55°℃~+85°℃	± 15%
S	X6S	-55°C ~+105°C	± 22%
Y	Y5V	-30°C ~+85°C	+22/-82%
Z	Z5U	+10°C ~+85°C	+22/-56%
E	Y5U	-30°C ~+85°C	+22/-56%

# (4)Capacitance unit :pico farads(pF)

` '	•	1	1 /
С	ode	Nominal Capacitance (pF)	
5	R0	5.0	
1	20	12.0	
1	51	150.0	
1	02	1,000.0	
1	03	10,000.0	
4	174	470,000.0	
1	05	1,000,000.0	
1	06	10,000,000.0	_

# ※. If there is a decimal point, it shall be expressed by an

English capital letter R

### (5)Capacitance Tolerance

` / •		
Code	Tolerance	Nominal Capacitance
В	± 0.10 pF	Less Than 10 pF
С	± 0.25 pF	(Include 10 pF)
D	± 0.50 pF	
Е	± 1.00 pF	
F	± 1.00 %	More Than 10 pF
G	± 2.00 %	
J	± 5.00 %	
K	± 10.0 %	
M	± 20.0 %	
Z	+80/-20 %	

# (6)Rated Voltage

Code	Rated Voltage (Vdc)
101	100
201	200
	250
	500
631	630
	101 201 251 501

### (7)Tapping

Code	Type
T	Tape & Reel
В	Bulk



# 3. Nominal Capacitance and Tolerance

## 3.1 Standard Combination of Nominal Capacitance and Tolerance

Class	Characteristic	Tolera	ance	Nominal Capacitance
I	NPO / SL	Less Then 10 pF	B (± 0.10 pF)	0.5,1,1.5,2,2.5,3
			C (± 0.25 pF)	0.5,1,1.5,2,2.5,3,3.5,4,4.5,5
			D (± 0.50 pF)	5,6,7,8,9,10
			E (± 1.00 pF)	6,7,8,9,10
		More Than 10 pF	F (±1.00 %)	E-12, E-24 series
			G (±2.00 %)	
			J (± 5.00 %)	
			K (± 10.0 %)	
П	X7R/X5R/X7E	K (± 10.0 %),	M (± 20.0 %)	E-3, E-6 series
	Y5V	M (± 20.0 %), Z	Z(+80/-20%)	E- 3 series
	Z5U			
	Y5U			

## 3.2 E series(standard Number)

Standard No.		Application Capacitance										
E- 3	1.0				1.0 2.2					4	.7	
E- 6	1	.0	1	.5	2	.2	3	.3	4	.7	6	.8
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
E-24	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
	1.1	1.3	1.6	2.0	2.4	3.0	3.6	4.3	5.1	6.2	7.5	9.1

# 4. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
I	NPO	-55°C ~ +125°C	<b>25</b> ℃
	SL	-55°C ~ +125°C	<b>25</b> ℃
П	X7R	-55°C ~ +125°C	<b>25</b> ℃
	X5R	-55°C ~ +85°C	<b>25</b> ℃
	X6S	-55°C ~ +105°C	<b>25</b> ℃
	Y5V	-30℃ ~ +85℃	<b>25</b> ℃
	Z5U	+10°C ~ +85°C	<b>25</b> ℃
	Y5U	-30°C ~ +85°C	<b>25</b> ℃
	Other	-25°C ~ +85°C	<b>25</b> ℃

# 5. Storage Condition

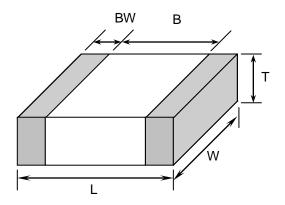
Storage Temperature : 5 to 40°C Relative Humidity : 20 to 70 % Storage Time : 12 months max.

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### 6. Dimensions

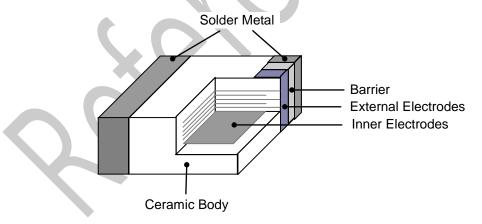
# **6.1 Configuration and Dimension:**



Unit:mm

TYPE	L	W	T (max)	B (min)	BW (min)
0201	$0.60 \pm 0.03$	$0.30 \pm 0.03$	0.33	0.20	0.10
0402	1.00± 0.05	0.50± 0.05	0.55	0.30	0.15
0603	1.60± 0.10	0.80± 0.10	1.00	0.40	0.15
0805	2.00± 0.20	1.25± 0.20	1.45	0.70	0.20
1206	$3.20 \pm 0.30$	1.60± 0.20	1.80	1.50	0.30
1210	3.20± 0.30	2.50± 0.20	2.60	1.60	0.30
1808	4.60± 0.30	2.00± 0.20	2.20	2.50	0.30
1812	4.60± 0.30	$3.20 \pm 0.30$	3.00	2.50	0.30
1825	4.60± 0.30	6.35± 0.40	2.60	2.50	0.30
2208	5.70± 0.40	2.00± 0.20	2.20	3.50	0.30
2211	5.70± 0.40	2.80± 0.40	3.00	3.50	0.30
2220	5.70± 0.40	5.00± 0.40	3.00	3.50	0.30
2225	5.70± 0.40	6.35± 0.40	3.00	3.50	0.30

# 6.2 Termination Type:





## 7. Performance

No.	Item		Specification		Test Condition	
1	Visua	ıl	No abnormal e	xterior appearance	Visual inspection	
2	Dimens	ion	See Page 3		Visual inspection	
3	Insulation Resistance		10,000MΩ or 5 Product Which	600/CΩ ever Is Smaller	V≦500V, Rated Voltage V>500V, Applied 500Vdc Charge Time: 60sec. Is applied less than 50mA current.	
4	Capacitance	Class	Within The Spec	cified Tolerance	Class I:	
		I NPO/SL			NPO/SL	
		Class II	Within The Spec	cified Tolerance	Capacitance Frequency Voltage  C≤1000pF 1MHz±10% 1.0±0.2Vrms  C>1000pF 1KHz±10%	
5	Q	Class	More Than 30pf		Class II :	
		I NPO/SL	30pF & Below: ( (C : Capacitano		Frequency Voltage X7R 1KHz±10% 1.0±0.2Vrms	
	Tanδ	Class	Char.	Maximum	Z5U/Y5U 1KHz±10% 1.0±0.2Vrms	
		П	X7R	2.5%	Perform a heat temperature at 150±5°C for 30min. then place room temp. for 24±2hr.	
	Withstan	dina	Z5U/Y5U	4.0%		
6	Withstanding Voltage		No dielectric breakdown or mechanical breakdown		200% /150%/120%/100% Rated Voltage For information which product has which applied voltage, please contact with HEC sales representative.  Voltage ramp up rate ≤ 500v/sec for 1~5 sec. charge/discharge Current is less than 50mA.  ※ Withstanding voltage testing requires immersion of the element in a isolation fluid prevent arcing on the chip surface, at voltage over 1000Vdc.	
7	Temperature	Class I	Char. Temp. Ra		Class I:	
	Capacitance Coefficient		NPO -55°C ~+1 SL -30°C ~+8		[C2-C1/C1(T2-T1)] x 100% Class [[:	
		Class II	Char. Temp. Ra X7R -55°C ~+1 Y5U -30°C ~+6 Z5U +10°C ~+	nge Cap. Change(%) 25°C ± 15% 85°C +22% ~-56%	(C2-C1)/C1 × 100% T1: Standard temperature (25℃) T2: Test temperature C1:Capacitance at standard temperature(25℃)	
8	Adhesive S	trength			C2: Capacitance at test temperature (T2) Pull force shall be applied for 10± 1 second.	
	of Termination		No indication of peeling shall occur on the terminal electrode.		≤06035N(= 0.5 Kg·f) >060310N(= 1.0 Kg·f) N·f	
9		Appear-	No mechanical	damage shall be occur.	Bending shall be applied to the 1.0 mm with	
	to Flexure of Substrate	ance C-Meter	Capacitance Ch Char. NPO SL X7R	ange Cap. Change ≤ ± 5.0% ≤ ± 5.0% ≤ ± 12.5%	1.0 mm/sec.  R230  Bending Limit  45±1mm  45±1mm	
			Y5U/Z5U	$\leq \pm 30.0\%$		



No.	Item			Specific	cation	Test Condition		
10		rability	More than 90% of the terminal surface			Solder Temperature : 245± 5°C		
10	Solde	Tability	is to be soldered newly, so metal part			Dip Time : 5 ± 0.5 sec.		
			does not come out or dissolve.			Immersing Speed : 25±10% mm/s		
						Solder : Lead Free Solder		
				<del>-</del> //	4	Flux :Rosin		
						Preheat : At 80~120 ℃ for 10~30sec		
11	Resistance	Appear-	No mech	hanical dam	age shall occur.	Class  ☐ capacitor shall be set for 48±4 hours at		
	То	ance				room temperature after one hour heat treatment		
	Soldering	Capacit-	Char	acteristic	Cap. Change	at 150 +0/-10°C before initial measure.		
	Heat	ance	Class I		Within ± 2.5% or	Preheat : At 150± 10℃ For 60~120sec.		
			(NPO/SI	L)	±0.25pFwhichev	Dip : Solder Temperature of 260± 5℃		
					er is larger of	Dip Time: 10 ± 1sec.		
			Class	VZD	initial value	Immersing Speed : 25±10% mm/s Flux :Rosin		
			Class	X7R Z5U/Y5U	Within ± 10% Within ± 20%	Tiux .itosiii		
		Q			ied initial value	Measure at room temperature after cooling for		
		Class I	10 oatioi	y and opcom	iod iiiiidi vaido	Class I : 24 ± 2 Hours		
		Tan δ	To satisf	y the specif	ied initial value	Class II : 48 ± 4 Hours		
		Class						
		Insulation	To satisf	y the specif	ied initial value			
		Resistance	To satisfy the specified initial value					
		Withstand Voltage	To satisf	y the specif	ied initial value			
40	Tempera			hanical dam	age shall occur	Class		
12	ture		110 111001	namoar dam	lago oriali occar	room temperature after one hour heat treatment		
	Cycle	Capacit-	Char	acteristic	Cap. Change	at 150 +0/-10 ℃ before initial measure.		
		ance	Class I		Within ± 2.5% or			
			er		±0.25pFwhichev	Capacitor shall be subjected to five cycles of the		
					er	temperature cycle as following:		
					is larger of initial	Step Temp.(°C) Time(min)		
			Class	X7R	value Within ± 7.5%	1 Min Rated Temp. +0/-3 30		
				Z5U/Y5U	Within ± 20%	2 25 3		
		Q			ied initial value	3 Max Rated Temp. +3/-0 30 4 25 3		
		Class I						
		Tan δ	To satisf	y the specif	ied initial value	Measure at room temperature after cooling for		
		Class II				Class I :24 ± 2 Hrs Class		
		Insulation	To satisf	y the specif	ied initial value	Solder the capacitor on P.C. board shown in Fig.		
		Resistance		,		2. before testing.		
13	Humidity	Appear-	No mech	hanical dam	age shall occur	Class II capacitor shall be set for 48± 4 hours at		
		ance		<u> </u>		room temperature after one hour heat treatment		
		Capacit-		cteristic	Cap. Change	at 150+0/-10 °C before initial measure.		
Ì		ance	Class I		Within ± 5.0% or	Temperature: 40± 2°C		
			(NPO/SI	,	±0.5pF whichever	Relative Humidity : 90 ~ 95%RH Test Time : 500 + 12/-0Hr		
					s larger of initial value	rest fille : 300   12/ Offi		
			Class		Within ± 15%	Measure at room temperature after cooling for		
			l —		Within ± 30%	Class I : 24 ± 2Hrs		
		Q		an 30pF : C		Class II : 48 ± 4Hrs		
		Class I			275 +2.5×C			
		Tan δ	Cha		Maximum	Solder the capacitor on P.C. board shown in Fig. 2, before testing		
		Class Ⅱ	X7F	3	5.0%	2. before testing.		
			Z5U/Y		5.0%			
		Insulation	1,000MΩ	Ω or 50/C	Ω whichever is			
I	Į.	1						

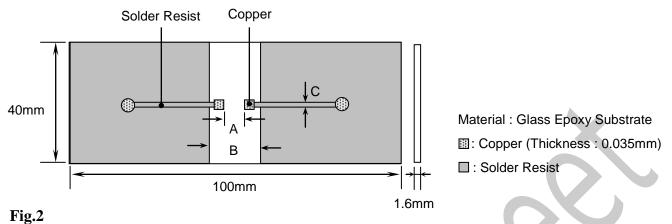
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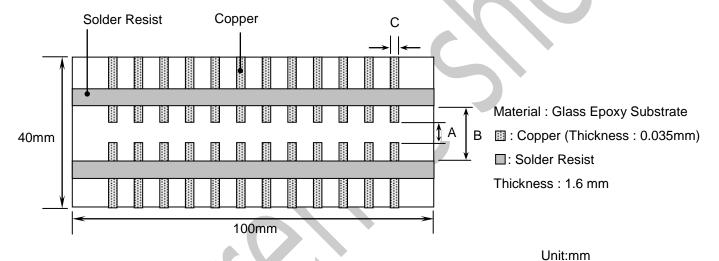
	R	Resistance	smaller.					
No.	Iter	m	S	pecific	cation		Test Condition	
14	High Temperature Load (Life Test)	Appear- ance Capacit- ance	No mechanica Characteri Class I (NPO/SL)			table) is a operation te 48±4 hours	pacitors applied DC voltage (following pplied for one hour at maximum emperature $\pm 3^{\circ}$ C then shall be set for at room temperature and the initial ent shall be conducted.	
			Class X7		r is larger Within ± 15% Within ± 30%	Applied Volt	tage : Applied Voltage	
		Q Class I Tan δ Class II	Char. X7R		275 + 2.5× C maximum 5.0%		150%Rated Voltage  120%Rated Voltage  100%Rated Voltage	
		Insulation Resistance	,		5.0% whichever is (C in Farad)	voltage, please contact with HEC sales represent temperature: max. operation temperature		
						Current App Measure at Class I: 24 Class II: 48	± 4 Hours	
15	Vibration	Appear- ance Capacit- ance	Characteric Class I (NPO/SL)  Class X7 II Z5U/	stic R Y5U	Cap. Change Within ± 2.5% or ±0.25pFwhichev er is larger Within ± 7.5% Within ± 20%	Fig 2. before testing.  Vibrate the capacitor with amplitude of 1 P-P changing the frequencies from 10Hz 55Hz and back to 10Hz in about 1 min.  Repeat this for 2 hours each in 3perpendic		
		Q Class I Tan δ Class II Insulation Resistance	To satisfy the	specif	ied initial value ied initial value ied initial value	directions.		



Fig.1
P.C. Board for Bending Strength Test



Test Substrate



Туре	Α	В	С
0201	0.2	0.9	0.4
0402	0.5	1.5	0.6
0603	1.0	3.0	1.0
0805	1.2	4.0	1.6
1206	2.2	5.0	2.0
1210	2.2	5.0	2.9
1808	3.5	7.0	2.5
1812	3.5	7.0	3.7
2208	4.5	8.0	2.5
2211	4.5	8.0	3.0
2220	4.5	8.0	5.6

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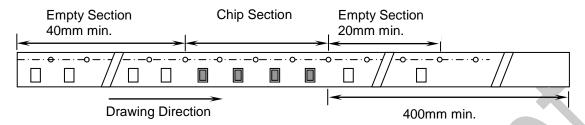


## 8. Packing

### 8.1 Bulk Packing

According to customer request.

## 8.2 Chip Capacitors Tape Packing



### 8.3 Material And Quantity

Tape	0201	0402	0603/0805		
Material	T≦0.33mm	T≦0.55mm	T≦0.90mm	T>0.90mm	
Paper	15,000 pcs/Reel	10,000 pcs/Reel	4,000 pcs/Reel	NA	
Plastic	NA	NA	NA	3,000 pcs/Reel	

Tape	1206						
Material	T≦0.90mm	0.90mm < T ≦ 1.25mm	T>1.25mm				
Paper	4,000 pcs/Reel	NA	NA				
Plastic	NA	3,000 pcs/Reel	2,000 pcs/Reel				

Tape	1808/1210						
Material	T≦1.25mm	1.25mm < T ≤ 2.40mm	T>2.40mm				
Paper	NA	NA	NA				
Plastic	3000 pcs/Reel	2000 pcs/Reel	500/1,000 pcs/Reel				

Tape	1812/22	11/2220	1825	2208	
Material	T≦2.20mm	T>2.20mm	T≦2.20mm	T>2.20mm	T≦2.20mm
Paper	NA	NA	NA	NA	NA
Plastic	1000 pcs/Reel	700 pcs/Reel	700 pcs/Reel	400 pcs/Reel	1000 pcs/Reel

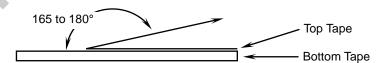
NA: Not Available

# 8.4 Cover Tape Reel Off Force

8.4.1 Peel-Off Force

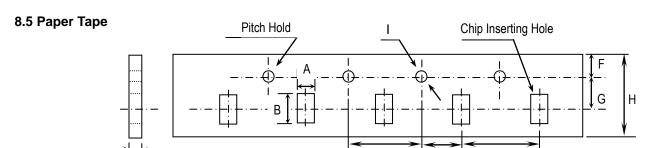
5 g·f  $\leq$  Peel-Off Force  $\leq$  70 g·f

8.4.2 Measure Method



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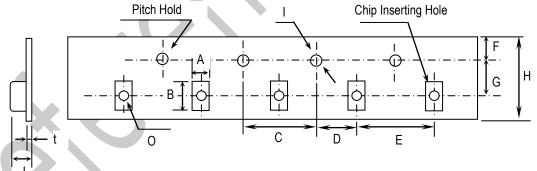


# Unit:mm

TYPE	Α	В	С	D	Е
0201	0.37± 0.1	0.67± 0.1	4.00± 0.1	$2.00 \pm 0.05$	$2.00 \pm 0.1$
0402	0.61± 0.1	1.20± 0.1			
0603	1.10± 0.2	1.90± 0.2			4.00± 0.1
0805	1.50± 0.2	2.30± 0.2			
1206	1.90± 0.2	3.50± 0.2			
1210	2.90± 0.2	3.60± 0.2			

TYPE	F	G	Н		t
0201	1.75± 0.10	$3.50 \pm 0.05$	8.0± 0.30	φ 1.50 +0.10/-0	1.10 max.
0402					
0603					
0805					
1206					
1210					

# 8.6 Plastic Tape



Unit:mm

Туре	А	В	С	D	Е	F
0805	1.5±0.2	2.3±0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
1206	1.9±0.2	3.5±0.2				
1210	2.9±0.2	3.6±0.2				
1808	2.5±0.2	4.9±0.2				
1812	3.6±0.2	4.9±0.2			8.0± 0.1	
1825	6.9±0.2	4.9±0.2				
2208	2.5±0.2	6.1±0.2				
2211	3.2±0.2	6.1±0.2				
2220	5.4±0.2	6.1±0.2				
2225	6.9±0.2	6.1±0.2				

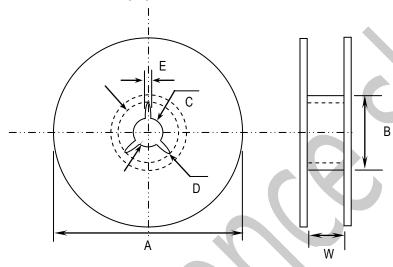
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Туре	G	Н		J	t	0
0805	3.5± 0.05	$8.0 \pm 0.3$	φ 1.5+0.1/-0	3.0 max.	0.3 max.	1.0± 0.1
1206						
1210						
1808	5.5± 0.05	$12.0 \pm 0.3$		4.0 max.		1.5± 0.1
1812						
1825						
2208						
2211						
2220						
2225					,	

# 8.7 Reel Dimensions

Reel Material : Polystyrene



Unit:mm

Type	Α	В	С	D	Е	W
0201	φ 382 max	φ 50 min	φ 13± 0.5	φ 21± 0.8	2.0±0.5	10± 0.15
0402						
0603						
0805						
1206						
1210						
1808	φ 178±0.2	φ 60±0.2				13±0.3
1812						
1825						
2208						
2211						
2220						
2225						

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### **Precautionary Notes:**

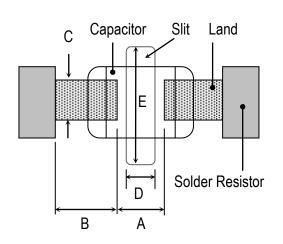
### 1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40°C and 70%RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

#### 2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

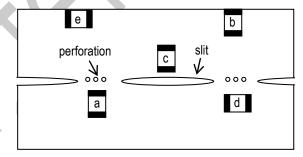
2.1 Size and recommend land dimensions for reflow soldering .



EIA Code Chip (mm)		Land (mm)					
EIA Code	L	W	Α	В	С	D	Ш
0201	0.60	0.30	0.2~0.3	0.2~0.4	0.2~0.4	-	-
0402	1.00	0.50	0.3~0.5	0.3~0.5	0.4~0.6		1
0603	1.60	0.80	0.4~0.6	0.6~0.7	0.6~0.8		1
0805	2.00	1.25	0.7~0.9	0.6~0.8	0.8~1.1		1
1206	3.20	1.60	2.2~2.4	0.8~0.9	1.0~1.4	1.0~2.0	3.2~3.7
1210	3.20	2.50	2.2~2.4	1.0~1.2	1.8~2.3	1.0~2.0	4.1~4.6
1808	4.60	2.00	2.8~3.4	1.8~2.0	1.5~1.8	1.0~2.8	3.6~4.1
1812	4.60	3.20	2.8~3.4	1.8~2.0	2.3~3.0	1.0~2.8	4.8~5.3
1825	4.60	6.35	2.8~3.4	1.8~2.0	5.1~5.8	1.0~4.0	7.1~8.3
2208	5.70	2.00	4.0~4.6	2.0~2.2	1.5~1.8	1.0~4.0	3.6~4.1
2211	5.70	2.80	4.0~4.6	2.0~2.2	2.0~2.6	1.0~4.0	4.4~4.9
2220	5.70	5.00	4.0~4.6	2.0~2.2	3.5~4.8	1.0~4.0	6.6~7.1
2225	5.70	6.35	4.0~4.6	2.0~2.2	5.1~5.8	1.0~4.0	7.1~8.3

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.
Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended. Susceptibility to stress is in the order of: a>b>c and d>e



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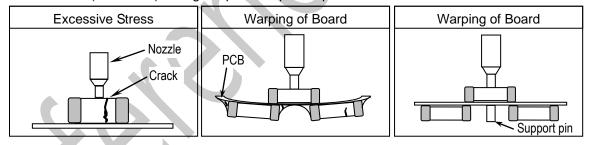


### 2.3 Layout Recommendation

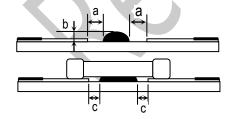
Example	Use of Common Solder Land	Solder With Chassis	Use of Common Solder Land With Other SMD
Need to Avoid	Chip Solder  Adhesive PCB Solder Land	Chassis  Excessive Solder	Solder Land
Recommendation	Chip Solder Resist  Adhesive Solder Land	Solder Resist $\beta$ $\alpha > \beta$	

### 3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



### 3.2 Amount of Adhesive



Example: 0805 & 1206

а	0.2mm min.
b	70 ~ 100 μm
С	Do not touch the solder land

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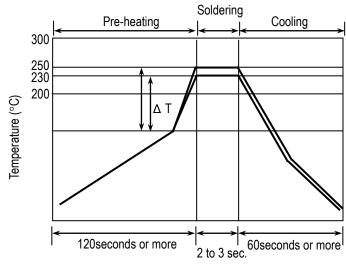


### 4. Soldering

#### 4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to 250°C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

### **Recommend flow soldering temperature Profile**



Soldering Method	Change in Temp.( °ℂ)
1206 and Under	$\Delta$ T ≤ 100~130 max.

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
  - a. Flux flows to easily
  - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
  - a. Flux deteriorates even when oxide film is removed
  - b. Causes warping of circuit board
  - c. Loss of reliability in chip and other components

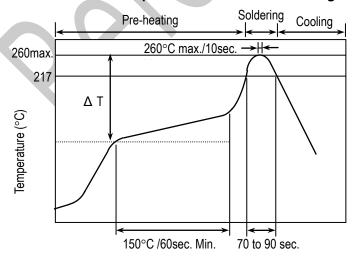
### Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference ( $\Delta$  T) between the solvent and the chips must be less than 100°C.

### 4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed 3°C/Sec.

### Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



### The cycles of soldering: Twice (max.)

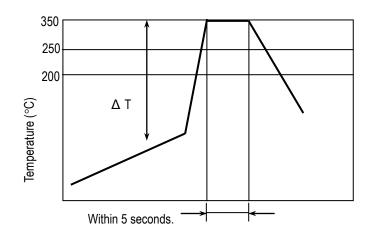
Soldering Method	Change in Temp.( °C)
1206 and Under	Δ T ≦ 190 °C
1210 and Over	Δ T ≦ 130 °C

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#### 4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



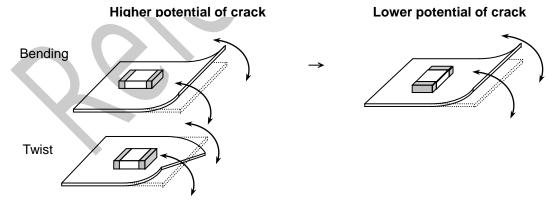
Soldering Method	Change in Temp.( °C)
1206 and Under	$\Delta$ T $\leq$ 150 $^{\circ}$ C
1210 and Over	$\Delta$ T $\leq$ 130 $^{\circ}$ C

### How to Solder Repair by Solder Iron

- 1) Selection of the soldering iron tip
  - The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.
- 2) recommended solder iron condition
  - a.) Preheating Condition: Board and components should be preheated sufficiently at 150°C or over, and soldering should be conducted with soldering iron as boards and components are maintained at sufficient temperatures.
  - b.) Soldering iron power shall not exceed 30 W.
  - c.) Soldering iron tip diameter shall not exceed 3mm.
  - d.) Temperature of iron tip shall not exceed 350°C., and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
  - f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
  - g.) After soldering operation, let the products cool down gradually in the room temperature.

### 5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.



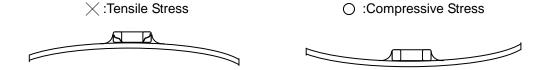
5.2 There is a potential of crack if board is warped due to excessive load by check pin



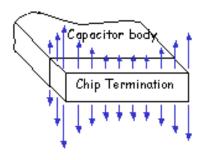
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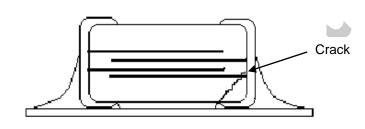


- 5.3 Mechanical stress due to warping and torsion.
  - (a) Crack occurrence ratio will be increased by manual separation.
  - (b) Crack occurrence ratio will be increased by tensile force, rather than compressive force.



## Capacitor Stress Analysis



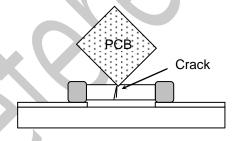


### 6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



# 7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40°C and under humidity of 20 to 70% RH. The shelf life of capacitors is 12 months.

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单击下面可查看定价,库存,交付和生命周期等信息

>>Holy Stone(禾伸堂)